On Variational Bounds of Mutual Information

-Summary-

Introduction

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- Mutual information (MI) : $I(X;Y) = \mathbb{E}_{p(x,y)}[p(x,y)\log\frac{p(x,y)}{p(x)p(y)}] = \mathbb{E}_{p(x,y)}[\log(\frac{p(y|x)}{p(x)})] = \mathbb{E}_{p(x,y)}[\log(\frac{p(x|y)}{p(y)})]$
- KL divergence : $KL(P||Q) = \int_{\mathcal{X}} p(x) \log \left(\frac{p(x)}{q(x)}\right) dx$ when $P \ll Q$
- Properties on MI required on paper
 - 1. I(X;Y) = KL(P(x,y)||p(x)p(y))
 - 2. $I(X; Y) \ge 0$
 - 3. When $X_1 \rightarrow X_2 \dots \rightarrow X_n$ forms Markov chain, $I(X_1; X_2, \dots X_n) = I(X_1; X_2)$
 - 4. I(X,Z;Y) = I(X;Y) if p(x,y,z) = p(x,y)p(z) (i.e : $Z \perp (X,Y)$)
- MI : measure independence between X, Y (i.e : I(X; Y) = 0 if $f(X \perp Y)$
- Problem : estimating MI is challenging as we don't have access to underlying distributions, but only the samples.

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- Usages of MI:
 - 1. Just estimation of MI
 - 2. Limit upper bound of MI to restrict the capacity or contents of representations.
 - 3. Maximize MI between a learned representation and an aspect of the data. (representation learning) (Given $x \sim p(x)$, learn a stochastic representation of the data $p_{\theta}(y|x)$ that maximize MI subject to constraints on the mapping)

Note: To maximize MI, we need to find a lower bound on MI with respect to parameter θ (Variational lower bound of MI), and use Gradient Descent to tighten the lower bound to actual MI.

Normalized upper bound (what does 'normalized' means?)

• Upper bounding MI is challenging, but is possible when p(y|x) is known

$$I(X;Y) = \mathbb{E}_{p(x,y)} \left[\log \frac{p(y|x)}{p(y)} \right] = \mathbb{E}_{p(x,y)} \left[\log \frac{p(y|x)}{q(y)} \right] - KL(p(y)||q(y)) \le \mathbb{E}_{p(x)} \left[KL(p(y|x)||q(y)) \right]$$

(Note : drop the KL(p(y)||q(y)| term)

where q(y) is variational approximation of p(y), which is intractable.

• $R \triangleq \mathbb{E}_{p(x)}[KL(p(y|x)||q(y)]$ is one of variational upper bound of MI

Normalized lower bounds (I_{BA})

- $I(X;Y) = \mathbb{E}_{p(x,y)}[\log \frac{q(x|y)}{p(x)}] + \mathbb{E}_{p(y)}[KL(p(x|y)||q(x|y))] \ge \mathbb{E}_{p(x,y)}[\log(q(x|y)) + h(X)]$ (drop the $\mathbb{E}_{p(y)}[KL(p(x|y)||q(x|y))]$ term)
- $I_{BA} \triangleq \mathbb{E}_{p(x,y)}[\log(q(x|y)] + h(X)]$ is a variational lower bound of MI
- Note : h(X) is differential entropy defined by $h(X) = \mathbb{E}_{p(x)}[-\log(p(X))] => \text{constant}$
- The bound is tight when q(x|y) = p(x|y) and $\mathbb{E}_{p(x,y)}[\log(q(x|y))] = -h(X|Y)$
- Note : $h(X|Y) = \mathbb{E}_{p(x,y)}[-\log(p(X|Y))]$
- Evaluating h(X) is intractable (and often unknown), but gradient of I_{BA} is tractable if q(x|y) [decoder on representation learning] is tractable (challenging when X is high dimensional and H(X|Y) is large)

Unnormalized lower bounds – backgrounds

- To avoid 'tractable' decoder, we turn to 'unnormalized' distributions for the variational family of q(x|y).
- Here, we choose energy-based variational family using 'critic' f(x, y) and scaled by p(x):

$$q(x|y) = \frac{p(x)}{Z(y)}e^{f(x,y)}$$
, where $Z(y) = \mathbb{E}_{p(x)}[e^{f(x,y)}]$

• Critic acts as loss function (if discrepancy between x, y is big, then gives high critic value f(x, y))

Unnormalized lower bounds (I_{UBA})

- Recall $I_{BA} = \mathbb{E}_{p(x,y)}[\log(q(x|y))] + h(X)$, HERE, put q(x|y) as a energy based variational family.
 - (Again, recall energy based variational family : $q(x|y) = \frac{p(x)}{Z(y)}e^{f(x,y)}$, where $Z(y) = \mathbb{E}_{p(x)}[e^{f(x,y)}]$)
- Then, we get $I(X;Y) \ge \mathbb{E}_{p(x,y)}[f(x,y)] \mathbb{E}_{p(y)}[logZ(y)] \triangleq I_{UBA}$
- Bound is tight when $f(x, y) = \log p(y|x) + c(y)$ where c(y) is solely a function of y.
 - (actually using condition q(x|y) = p(x|y), we can deduce $c(y) = \log \frac{Z(y)}{p(y)}$)
- Note: By scaling q(x|y) by p(x), we could remove intractable h(X) term.
- Problem : $\log partition function log Z(y)$ is intractable.

Unnormalized lower bounds (I_{DV})

- To avoid intractable log partition function $\log Z(y)$ in I_{UBA} , We use Jensen's inequality to $\mathbb{E}_{p(y)}[\log Z(y)]$ term on I_{UBA} .
- $\mathbb{E}_{p(y)}[\log Z(y)] \leq \log(\mathbb{E}_{p(y)}[Z(y)])$ using concavity of log and Jensen's inequality.
- Then, we get $I(X,Y) \ge I_{UBA} \ge \mathbb{E}_{p(x,y)}[f(x,y)] \log(\mathbb{E}_{p(y)}[Z(y)]) \triangleq I_{DV}$
- Problem : Achieving I_{DV} is still intractable in practice.
- One may use the inequality $\log Z(y) = \log \mathbb{E}_{p(x)}[e^{f(x,y)}] \ge \mathbb{E}_{p(x)}[\log(e^{f(x,y)})] = \mathbb{E}_{p(x)}[f(x,y)]$ to upper bound the $\log Z(y)$ term in I_{UBA} AND use MC approximation. but this gives neither an upper and lower bound. (Since this becomes upper bound of I_{UBA} , which is an lower bound of MI)

Unnormalized lower bounds (I_{TUBA})

• To form a tractable bound (especially deal with log partition), we use following inequality

$$\log(x) \le \frac{x}{a} + \log(a) - 1 \text{ for all } x, a > 0$$

(this get tight when x = a)

- Then, $\log Z(y) \le \frac{Z(y)}{a(y)} + \log(a(y)) 1$, for some function a(y) > 0 and this get tight when a(y) = Z(y)
- Applying this inequality on $I_{UBA} = \mathbb{E}_{p(x,y)}[f(x,y)] \mathbb{E}_{p(y)}[logZ(y)]$, we get following :

$$\mathbb{E}_{p(x,y)}[f(x,y)] - \mathbb{E}_{p(y)}\left[\frac{\mathbb{E}_{p(x)}[e^{f(x,y)}]}{a(y)} + \log(a(y)) - 1\right] \triangleq I_{TUBA}$$

To tighten this lower bound, we can maximize this bound w.r.t variational parameters a(y) and f.

Unnormalized lower bounds (I_{NWI})

• To simplify the I_{TUBA} , put a(y) = e ,which yields I_{NWI} :

$$I_{NWJ} = \mathbb{E}_{p(x,y)}[f(x,y)] - e^{-1}\mathbb{E}_{p(y)}[Z(y)]$$

Note: there exists a unique optimal critic $f^*(x,y) = 1 + \log(\frac{p(x|y)}{p(x)})$ such that $I_{NWJ} = I(X;Y)$.

Note: We can also choose $a(y) = \frac{1}{K} \sum_{i=1}^{K} e^{f(x_i, y_i)}$ (scalar exponential moving average, EMA), where K = minibatch size, then, the gradient of I_{TUBA} yields the 'improved MINE gradient estimator'

Multi-sample unnormalized lower bounds

- To reduce variance of variational bounds, we extend the unnormalized bounds to depend on multiple samples.
- Goal : estimate $I(X_1; Y)$ given samples from $p(x_1)p(y|x_1)$ and access to K-1 additional samples $x_{2:k} \sim r^{K-1}(x_{2:K}) = \prod_{i=2}^K p(x_i)$.
- Note: We assume $X_1, ... X_K$ are independent (not sure...or assuming Markov chain), so using fact: I(X,Z;Y) = I(X;Y) if $Z \perp (X,Y)$, we get $I(X_1;Y) = I(X_1,...X_K;Y)$
- Recall : $f^*(x,y) = 1 + \log(\frac{p(x|y)}{p(x)})$ on $I_{NWJ} = \mathbb{E}_{p(x,y)}[f(x,y)] e^{-1}\mathbb{E}_{p(y)}[Z(y)]$

Using this, the optimal critic for multi sample case : $f^*(x_{1:k}, y) = 1 + \log\left(\frac{p(y|x_{1:k})}{p(y)}\right) = 1 + \log\left(\frac{p(y|x_1)}{p(y)}\right)$

=> Critics now also depends on the additional samples $x_{2:K}$

Multi-sample unnormalized lower bounds (I_{NWI})

• By setting, the critic $f(x_{1:k}, y) = 1 + \log \frac{e^{f(x_1, y)}}{a(y; x_1, y)}$ and $r^{K-1}(x_{2:K}) = \prod_{j=2}^K P(x_j)$, the multi-sample I_{NWJ} becomes (the RHS term):

$$I(X_1; Y) \ge 1 + \mathbb{E}_{p(x_{1:K})p(y|X_1)} \left[\log \frac{e^{f(x_1, y)}}{a(y; x_{1:K})} \right] - \mathbb{E}_{p(x_{1:K})p(y)} \left[\frac{e^{f(x_1, y)}}{a(y; x_{1:K})} \right]$$

• One way to exploit additional sample $x_{2:K}$ from p(x) is to use MC estimate of the partition function Z(y):

$$\Rightarrow$$
 Set $a(y; x_{1:K}) = m(y; x_{1:K}) = \frac{1}{K} \left(\sum_{i=1}^{K} e^{f(x_i, y)} \right) \cong Z(y)$

• Then, the last term $\mathbb{E}_{p(x_{1:K})p(y)}\left[\frac{e^{f(x_1,y)}}{m(y;x_{1:K})}\right] = \frac{1}{K}\sum_{i=1}^{K}\mathbb{E}_{p(x_{1:K})p(y)}\left[\frac{e^{f(x_i,y)}}{m(y;x_{1:K})}\right] = 1$, Thus, we get I_{NCE} :

$$I(X;Y) \ge \mathbb{E}\left[\frac{1}{K}\sum_{i=1}^K\log\frac{e^{f(x_i,y_i)}}{\frac{1}{K}\sum_{j=1}^K e^{f(x_i,y_i)}}\right]$$
, where expectation is taken over $\Pi_j p(x_j,y_j)$

Multi-sample unnormalized lower bounds (I_{NWI} , I_{α})

- Note : $I_{NCE} < \log K$ and the optimal critic for I_{NCE} is $f(x,y) = \log p(y|x) + c(y)$ Therefore, if $I(X;Y) > \log K$, then the lower bound (I_{NWI}) may be loose.
- Note : I_{NWI} : low-bias, high variance estimator $\Leftrightarrow I_{NCE}$: high-bias, low-variance estimation.
- To get a continuum between I_{NWJ} and I_{NCE} , set $f(x_{1:k},y)=1+\log\frac{e^{f(x_1,y)}}{\alpha m(y;x_{1:K})+(1-\alpha)q(y)}$ with $\alpha\in[0,1]$, then we get following lower bound I_{α} :

$$1 + \mathbb{E}_{p(x_{1:K})p(y|x_1)} \left[\log \frac{e^{f(x_1,y)}}{\alpha m(y;x_{1:K}) + (1-\alpha)q(y)} \right] - \mathbb{E}_{p(x_{1:K})p(y)} \left[\frac{e^{f(x_1,y)}}{\alpha m(y;x_{1:K}) + (1-\alpha)q(y)} \right]$$

• Note : $I_{NWJ}(\alpha=0)$ and $I_{NCE}(\alpha=1)$ and $I_{\alpha}<\log\frac{K}{\alpha}$

Structured bounds with tractable encoders

- When the conditional distribution p(y|x) is known (This case is common in representation learning), we can use previous bounds to find upper bound.
- Recall $R \triangleq \mathbb{E}_{p(x)}[KL(p(y|x)||q(y)]$, which is an upper bound of MI.

Given a minibatch of $K(x_i, y_i)$ pairs, we can approximate $p(y) \cong \frac{1}{K} \sum_{i=1}^{K} p(y|x_i)$ and $q_i(y) = \frac{1}{K-1} \sum_{j \neq i} p(y|x_j)$. Using this, we can upper bound MI by following :

$$I(X;Y) \le \mathbb{E}\left[\frac{1}{K} \sum_{i=1}^{K} \left[\log \frac{p(y_i|x_i)}{\frac{1}{K-1} \sum_{j \ne i} p(y_i|x_i)} \right] \right]$$

where the expectation is over $\Pi_i p(x_i, y_i)$.

• Using I_{NCE} and this upper bound, we can sandwich MI without introducing learned variational distribution.

Experiments

Comparing estimates across different lower bounds

- Experiment environment :
 - (x,y) are drawn from 20-dim Gaussian distribution with correlation $\rho(t)$, where t = step
 - $(x, (Wy)^3)$ are also prepared using $W_{ij} \sim N(0,1)$ and cubic exponent done by element-wise.
 - Note : $I(X;Y) = I(X;(WY)^3)$ (full rank linear transformation does not change MI)

